Notice of References Cited 10/784,566 Reexamination JIN ET AL. Fxaminer Art Unit

10/784,566

JIN ET AL.

Examiner

Art Unit

Jermele M. Hollington

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Applicant(s)/Patent Under

U.S. PATENT DOCUMENTS

Application/Control No.

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	· Name	Classification
	Α	US-6,146,970 A	11-2000	Witek et al.	438/424
	В	US-6,563,173 B2	05-2003	Bolam et al.	257/349
	С	US-6,627,484 B1	09-2003	Ang, Boon Yong	438/154
	D	US-6,627,954 B1	09-2003	Seefeldt, James D.	257/350
	E	US-6,759,865 B1	07-2004	Gu et al.	324/765
	F	US-6,774,395 B1	08-2004	Lin et al.	438/18
	G	US-6,849,928 B2	02-2005	Cha et al.	257/647
	Н	US-6,847,218 B1	01-2005	Nulty et al.	324/754
	ı	US-6,483,330 B1	11-2002	Kline, Jerry D.	324/754
	J	US-6,452,411 B1	09-2002	Miller et al.	324/765
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ъ					·
	O					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.